Search Notes	

Application/Control No.	Applicant(s)/Paten Reexamination	t under
10/017,554	PARK ET AL.	
Examiner	Art Unit	
Binh Q. Nguyen	2664	

SEARCHED			
Class	Subclass	Date	Examiner
370	310.1 310.2	8/11/2005	BQN
370	332	8/12/2005	BQN
370	329	8/11/2005	BQN
370	328	8/11/2005	BQN
370	335	8/11/2005	BQN
370	342	8/15/2005	BQN
370	352	8/11/2005	BQN
455	550.1	8/11/2005	BQN
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)- See Search History Printout	8/11/2005	BQN
EAST, consulted Wellinton Chin	8/15/2005	BQN
Final Reject, consulted Wellington Chin	1/26/2005	BQN
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